Notice of References Cited

Application/Control No. Applicant(s)/Patent Under Reexamination 09/894,083 JOHN ET AL. Art Unit Examiner Page 1 of 1 A. Sefer 2826

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	4	US-6,384,453	05-2002	Yanagigawa	257/355
E	в	US-6,348,716	02-2002	Yun	257/356
-	=	US-5,612,564	03-1997	Fujishima et al	257/341
-	5	US-5,969,387	10-1999	Letavic et al	257/347
E	E	US-5,907,181	05-1999	Han et al	257/630
F	F	US-5,912,495	06-1999	Depetro et al	257/355
(3	US-6,414,831	07-2002	Orchard-Webb	361/111
ŀ	н	US-4,928,157	05-1990	Matsunaga et al	357/23.13
	1	US-			
	J	US-			
P	к	US-			
ı	L	US-			
N	м	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2000-114266	04-2000	Japan	Yanagawa	
	0	FR 2754406	04-1998	France	Sicard	
	Р	DE 3122352	01-1983	Germany	Meinders	
	Q					
	R					
	s					
	т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	C	
	v	
	w	
	×	

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.